## TOSHIBA

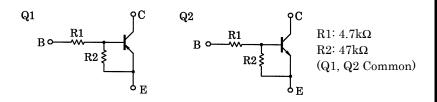
TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process) Silicon NPN Epitaxial Type (PCT Process)

# **RN4606**

Switching, Inverter Circuit, Interface Circuit And Driver Circuit Applications

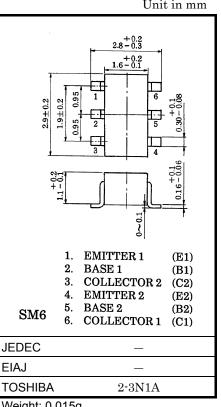
- Including two devices in SM6 (super mini type with 6 leads)
- With built-in bias resistors •
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process •

#### **Equivalent Circuit and Bias Resister Values**



#### Q1 Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	-50	V
Collector-emitter voltage	V <sub>CEO</sub>	-50	V
Emitter-base voltage	V <sub>EBO</sub>	-5	V
Collector current	Ι <sub>C</sub>	-100	mA



Weight: 0.015g

#### Q2 Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	50	V
Collector-emitter voltage	V <sub>CEO</sub>	50	V
Emitter-base voltage	V <sub>EBO</sub>	5	V
Collector current	Ι <sub>C</sub>	100	mA

Unit in mm

#### Q1, Q2 Common Absolute Maximum Ratings (Ta = 25°C)

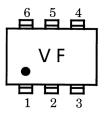
Characteristic	Symbol	Rating	Unit
Collector power dissipation	P <sub>C</sub> *	300	mW
Junction temperature	Тј	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

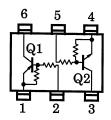
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

\* Total rating

#### Marking



#### Equivalent Circuit (Top View)



#### Q1 Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	_	$V_{CB} = -50V, I_E = 0$	_	_	-100	nA
	ICEO	-	$V_{CE} = -50V, I_B = 0$	_	_	-500	
Emitter cut-off current	I <sub>EBO</sub>	-	$V_{EB} = -5V, I_C = 0$	-0.074	_	-0.138	mA
DC current gain	h <sub>FE</sub>	-	$V_{CE} = -5V, I_C = -10mA$	80	_	—	_
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	_	I <sub>C</sub> = −5mA, I <sub>B</sub> = −0.25mA	—	-0.1	-0.3	V
Input voltage (ON)	V <sub>I (ON)</sub>	_	$V_{CE} = -0.2V, I_C = -5mA$	-0.7	_	-1.3	V
Input voltage (OFF)	VI (OFF)	_	$V_{CE} = -5V, I_C = -0.1mA$	-0.5	_	-0.8	V
Transition frequency	f <sub>T</sub>	_	V <sub>CE</sub> = −10V, I <sub>C</sub> = −5mA	—	200	—	MHz
Collector output capacitance	C <sub>ob</sub>	_	$V_{CB} = -10V, I_E = 0$	—	3	6	pF

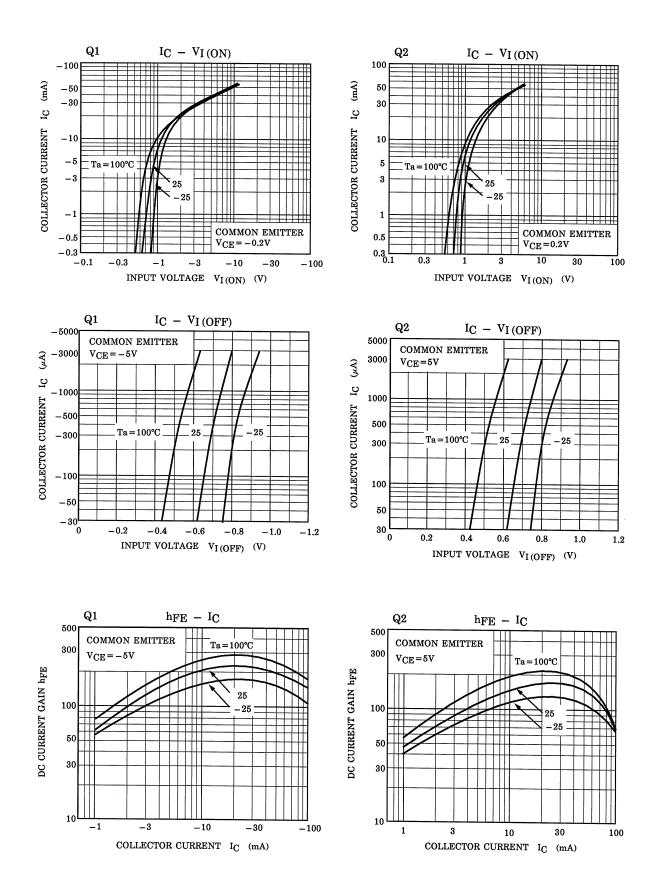
#### Q2 Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Collector cut-off current	I <sub>CBO</sub>	_	$V_{CB} = 50V, I_E = 0$	—	—	100	nA	
	ICEO	-	V <sub>CE</sub> = 50V, I <sub>B</sub> = 0	_	-	500	ПА	
Emitter cut-off current	I <sub>EBO</sub>	-	V <sub>EB</sub> = 5V, I <sub>C</sub> = 0	0.074	_	0.138	mA	
DC current gain	h <sub>FE</sub>	-	V <sub>CE</sub> = 5V, I <sub>C</sub> = 10mA	80	-	_	_	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	-	I <sub>C</sub> = 5mA, I <sub>B</sub> = 0.25mA	—	0.1	0.3	V	
Input voltage (ON)	V <sub>I (ON)</sub>	-	V <sub>CE</sub> = 0.2V, I <sub>C</sub> = 5mA	0.7	-	1.3	V	
Input voltage (OFF)	VI (OFF)	-	V <sub>CE</sub> = 5V, I <sub>C</sub> = 0.1mA	0.5	_	0.8	V	
Transition frequency	fŢ	_	V <sub>CE</sub> = 10V, I <sub>C</sub> = 5mA	_	250	_	MHz	
Collector output capacitance	C <sub>ob</sub>	_	V <sub>CB</sub> = 10V, I <sub>E</sub> = 0, f = 1 MHz	_	3	6	pF	

#### Q1, Q2 Common Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	—	3.29	4.7	6.11	kΩ
Resistor ratio	R1/R2	_	—	0.09	0.1	0.11	—

### **TOSHIBA**



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20070701-EN GENERAL

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